SN54ALS174, SN54ALS175, SN54AS174, SN54AS175A SN74ALS174, SN74ALS175, SN74AS174, SN74AS175B HEX/QUADRUPLE D-TYPE FLIP-FLOPS WITH CLEAR SDAS207C - APRIL 1982 - REVISED OCTOBER 1995

- 'ALS174 and 'AS174 Contain Six Flip-Flops With Single-Rail Outputs
- 'ALS175, SN54AS175A, and SN74AS175B Contain Four Flip-Flops With Double-Rail Outputs
- Buffered Clock and Direct-Clear Inputs
- Applications Include:
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators
- Fully Buffered Outputs for Maximum Isolation From External Disturbances ('AS Only)
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These positive-edge-triggered flip-flops utilize TTL circuitry to implement D-type flip-flop logic. All have a direct-clear ($\overline{\text{CLR}}$) input, and the 'ALS175, SN54AS175A, and SN74AS175B feature complementary outputs from each flip-flop.

Information at the data (D) inputs meeting the setup-time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock (CLK) input is at either the high or low level, the D-input signal has no effect at the output.

These circuits are fully compatible for use with most TTL circuits.

The SN54ALS174, SN54ALS175, SN54AS174, and SN54AS175A are characterized for operation over the full military temperature range of -55° C to 125°C. The SN74ALS174, SN74ALS175, SN74AS174, and SN74AS175B are characterized for operation from 0°C to 70°C.

SN54ALS174, SN54AS174 J PACKAGE SN74ALS174, SN74AS174 D OR N PACKAGE (TOP VIEW)										
		16	V _{CC}							
h	2	15	6Q							
1D [3	14	6D							
2D [4	13	5D							
2Q [5	12	5Q							
3D [6	11	4D							
3Q [7	10	4Q							
GND [8	9	CLK							

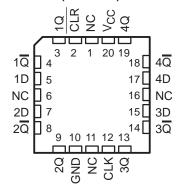
SN54ALS174, SN54AS174... FK PACKAGE (TOP VIEW)

	CLR CCR 60 CC	
1D	3 2 1 20 19 4 18	6D
2D	5 17	5D
1D 2D NC 2Q 3D		NC
2Q	7 15	5Q 4D
3D	8 10 11 10 10 14	4D
I	A C N D M A C N D M A C N D M	
	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	

SN54ALS175, SN54AS175A . . . J PACKAGE SN74ALS175, SN74AS175B . . . D OR N PACKAGE (TOP VIEW)

,			-••,	
CLR [ 1Q [ 1Q [ 1D [ 2D [ 2Q [ 300 ]	2 3 4 5 6	U	16 15 14 13 12 11 10 9	V _{CC} 4Q 4D 3D 3Q 3Q CLK

SN54ALS175A, SN54AS175A... FK PACKAGE (TOP VIEW)



NC - No internal connection

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

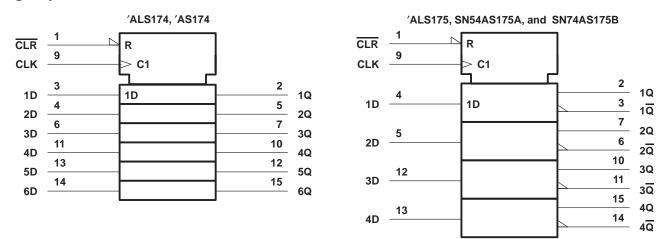


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FUNCTION TABLE (each flip-flop)								
INPUTS OUTPUTS								
CLR	CLK	D	<u>a</u> t					
L	Х	Х	L	Н				
н	$\uparrow$	Н	н	L				
н	$\uparrow$	L	L	н				
н	L	Х	Q ₀	$\overline{Q}_0$				

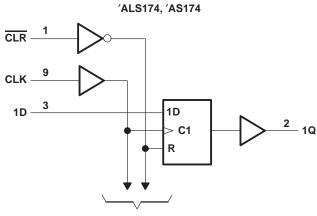
†'ALS175, SN54AS175A, and SN74AS175B only

## logic symbols[‡]



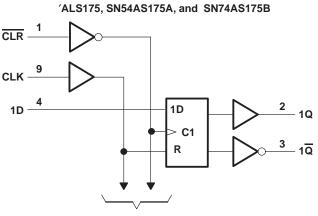
[‡] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.

## logic diagrams (positive logic)



**To Five Other Channels** 

Pin numbers shown are for the D, J, and N packages.



**To Three Other Channels** 



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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC}	
Operating free-air temperature range, T _A : SN54ALS174, SN54ALS175	-55°C to 125°C
SN74ALS174, SN74ALS175	0°C to 70°C
Storage temperature range	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

			-	54ALS1 54ALS1		-	SN74ALS174 SN74ALS175		UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage				0.8			0.8	V
ЮН	High-level output current				-0.4			-0.4	mA
IOL	Low-level output current				4			8	mA
fclock	Clock frequency		0		40	0		50	MHz
		CLR low	15			10			
tw	Pulse duration	CLK high	12.5			10			ns
		CLK low	12.5			10		M MAX 5 5.5 0.8 -0.4 8	
		Data	15			10			
t _{su}	Setup time before CLK [↑]	CLR inactive	8			6			ns
t _h	Hold time, data after $CLK{\uparrow}$		0			0			ns
TA	Operating free-air temperature		-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST C	TEST CONDITIONS		SN54ALS174 SN54ALS175			SN74ALS174 SN74ALS175			
				MIN	TYP‡	MAX	MIN	TYP‡	MAX		
VIK		V _{CC} = 4.5 V,	lı = -18 mA			-1.5			-1.5	V	
VOH		$V_{CC} = 4.5 V \text{ to } 5.5 V,$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2			V _{CC} -2	2		V	
Vai		V _{CC} = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	- V	
VOL		VCC = 4.5 V	I _{OL} = 8 mA					0.35	0.5		
Ц		V _{CC} = 5.5 V,	$V_{I} = 7 V$			0.1			0.1	mA	
IIН		V _{CC} = 5.5 V,	VI = 2.7 V			20			20	μΑ	
1	All others		VI = 0.4 V			-0.1			-0.1	A	
ΙL	CLK	$V_{CC} = 5.5 V,$	V] = 0.4 V			-0.15				mA	
IO§		V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
1	'ALS174		See Note 1		11	19		11	19	A	
ICC	'ALS175	$V_{CC} = 5.5 V,$	See Note 1		8	14		9	14	mA	

[‡] All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}. NOTE 1: I_{CC} is measured with D inputs and CLR grounded, and CLK at 4.5 V.



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#### switching characteristics (see Figure 1)

PARAMETER	FROM	то	V( Cl Rl TA	UNIT				
	(INPUT)	(OUTPUT)	SN54ALS174 SN54ALS175		SN74ALS174 SN74ALS175			
			MIN	MAX	MIN	MAX		
fmax			40		50		MHz	
tPLH		Any Q ('ALS175)	3	20	5	18	ns	
^t PHL	CLR	Any Q	5	30	8	23	115	
tPLH	CLK	Any Q	3	20	3	15	ns	
^t PHL	ULN	(or Q, 'ALS175)	5	24	5	17	115	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, V _{CC}		
Input voltage, V ₁		
Operating free-air temperature range, T _A :	SN54AS174, SN54AS175A	–55°C to 125°C
	SN74AS174, SN74AS175B	0°C to 70°C
Storage temperature range		–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

				-	N54AS17 54AS17			SN74AS174 SN74AS175B		UNIT
				MIN	NOM	MAX	MIN	NOM	MAX	
VCC	Supply voltage			4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input volta	ge		2			2			V
VIL	Low-level input voltag	je				0.8			0.8	V
ЮН	High-level output curr	rent				-2			-2	mA
IOL	Low-level output curre	ent				20			20	mA
fclock*	Clock frequency			0		100	0		100	MHz
		CLR low	CLR low				5			
		CLK high		4			4			
tw*	Pulse duration		′AS174	6			6			ns
		CLK low	SN54AS175A, SN74AS175B	5			5			
			'AS174	4			4			
t _{su} *	Setup time before CLK↑	Data	SN54AS175A, SN74AS175B	3			3			ns
		CLR inactive	9	6			6			
t _h *	Hold time, data after (	CLK1	K↑				1			ns
Тд	Operating free-air tem	nperature		-55		125	0		70	°C

* On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.



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#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CC	TEST CONDITIONS		SN54AS174 SN54AS175A			SN74AS174 SN74AS175B		
				MIN	түр†	MAX	MIN	түр†	MAX	
VIK		V _{CC} = 4.5 V,	lj = – 18 mA			-1.2			-1.2	V
Vон		V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2			V
VOL		V _{CC} = 4.5 V,	I _{OL} = 20 mA		0.35	0.5		0.35	0.5	V
Ц		$V_{CC} = 5.5 V,$	$V_{I} = 7 V$			0.1			0.1	mA
Чн		$V_{CC} = 5.5 V,$	V _I = 2.7 V			20			20	μΑ
١ _{IL}		V _{CC} = 5.5 V,	$V_I = 0.4 V$			-0.5			-0.5	mA
10‡		V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA
	′AS174		See Note 2		30	45		30	45	~^^
ICC	SN54AS175A, SN74AS175B	V _{CC} = 5.5 V,	See Note 2		22.5	34		22.5	34	mA

[†] All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}. NOTE 2: I_{CC} is measured with D inputs, CLR, and CLK grounded.

#### switching characteristics (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPUT)		CL RL	C = 4.5 = 50 pF = 500 Ω = MIN t	<u>)</u> ,	',	UNIT
			SN54AS174		SN74AS174		
			MIN	MAX	MIN	MAX	
f _{max} *			100		100		MHz
^t PHL	CLR	Any Q	5	15	5	14	ns
^t PLH	CLK	Any Q	3.5	9.5	3.5	8	ns
^t PHL		AnyQ	4.5	11.5	4.5	10	115

* On products compliant to MIL-STD-883, Class B, these parameters are based on characterization data but are not production tested. § For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

#### switching characteristics (see Figure 1)

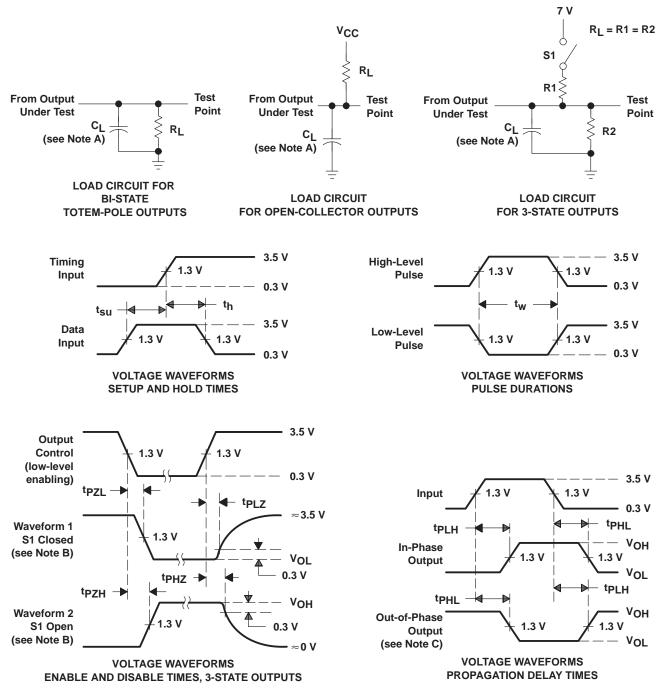
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R _L = 500 Ω, T _A = MIN to MAX§				UNIT
		()	SN54AS175A		SN74AS175B		
			MIN	MAX	MIN	MAX	
^f max*			100		100		MHz
^t PLH		A 0	4	10	4	4 9	
^t PHL	CLR	Any Q or $\overline{Q}$	4.5	15	4.5	13	ns
^t PLH	CLK	Any Q or Q	4	8.5	3	7.5	ns
^t PHL			4	11	3	10	115

* On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested. § For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_{f}$  =  $t_{f}$  = 2 ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

#### Figure 1. Load Circuits and Voltage Waveforms



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Parameter Name SN54AS175A

Voltage Nodes (V) 5

>> <u>Semiconductor Home</u> > <u>Products</u> > <u>Digital Logic</u> > Flip-Flops > <u>D-Type Flip-Flops</u> >

## SN54AS175A, Quadruple D-type Flip-Flops With Clear

**Device Status: Active** 

- > Description
- Features

|--|

- > Pricing/Samples/Availability
- > <u>Application Notes</u>
- > Related Documents
- Training

## Description

These positive-edge-triggered flip-flops utilize TTL circuitry to implement D-type flip-flop logic. All have a direct-clear (CLR\) input, and the 'ALS175, SN54AS175A, and SN74AS175B feature complementary outputs from each flip-flop.

Information at the data (D) inputs meeting the setup-time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock (CLK) input is at either the high or low level, the D-input signal has no effect at the output.

These circuits are fully compatible for use with most TTL circuits.

# The SN54ALS174, SN54ALS175, SN54AS174, and SN54AS175A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS174, SN74ALS175, SN74AS174, and SN74AS175B are characterized for operation from 0°C to 70°C

## Features

- ´ALS174 and ´AS174 Contain Six Flip-Flops With Single-Rail Outputs
- ALS175, SN54AS175A, and SN74AS175B Contain Four Flip-Flops With Double-Rail Outputs
- Buffered Clock and Direct-Clear Inputs
- Applications Include:
  - Buffer/Storage Registers
  - Shift Registers
  - Pattern Generators
- Fully Buffered Outputs for Maximum Isolation From External Disturbances ('AS Only)
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

To view the following documents, <u>Acrobat Reader 3.x</u> is required. To download a document to your hard drive, right-click on the link and choose 'Save'.

## Datasheets

Full datasheet in Acrobat PDF: <u>sdas207c.pdf</u> (116 KB) Full datasheet in Zipped PostScript: <u>sdas207c.psz</u> (114 KB)

## Pricing/Samples/Availability

Orderable Device	<u>Package</u>	<u>Pins</u>	<u>Temp (°C)</u>	<u>Status</u>	<u>Price/unit</u> USD (100-999)	<u>Pack Qty</u>	DSCC Number	<u>Availability / Samples</u>
5962-9553701Q2A	<u>FK</u>	20	-55 TO 125	ACTIVE	10.61	1		Check stock or order
5962-9553701QFA	W	16	-55 TO 125	ACTIVE	9.77	1		Check stock or order

SN54AS175AJ	Ī	16	-55 TO 125	ACTIVE	3.09	1		Check stock or order
SNJ54AS175AFK	<u>FK</u>	20	-55 TO 125	OBSOLETE				
SNJ54AS175AJ	Ī	16	-55 TO 125	ACTIVE	3.59	1	5962-9553701QEA	Check stock or order
SNJ54AS175AW	W	16	-55 TO 125	OBSOLETE				

## **Application Reports**

## View Application Reports for Digital Logic

- Advanced Schottky (ALS and AS) Logic Families (SDAA010 Updated: 08/01/1995)
- Advanced Schottky Load Management (SDYA016 Updated: 02/01/1997)
- Designing With Logic (SDYA009C Updated: 06/01/1997)
- Input And Output Characteristics Of Digital Integrated Circuits (SDYA010 Updated: 10/01/1996)
- Live Insertion (SDYA012 Updated: 10/01/1996)

## **Related Documents**

- Documentation Rules (SAP) And Ordering Information (SZZU001B, 4 KB Updated: 05/06/1999)
- Logic Selection Guide Second Half 2000 (SDYU001N, 5035 KB Updated: 04/17/2000)
- MicroStar Junior BGA Design Summary (SCET004, 284 KB Updated: 07/28/2000)
- More Power In Less Space Technical Article (SCAU001A, 850 KB Updated: 03/01/1996)

## Table Data Updated on: 9/1/2000

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